

# **Device Modeling Report**

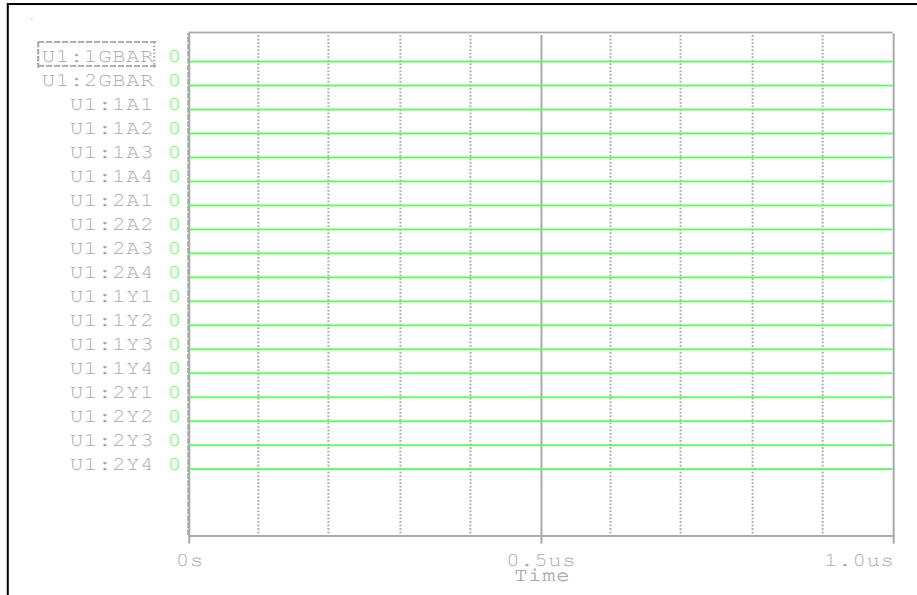
COMPONENTS : CMOS DIGITAL INTEGRATED CIRCUIT  
PART NUMBER : TC74ACT244FT  
MANUFACTURER : TOSHIBA



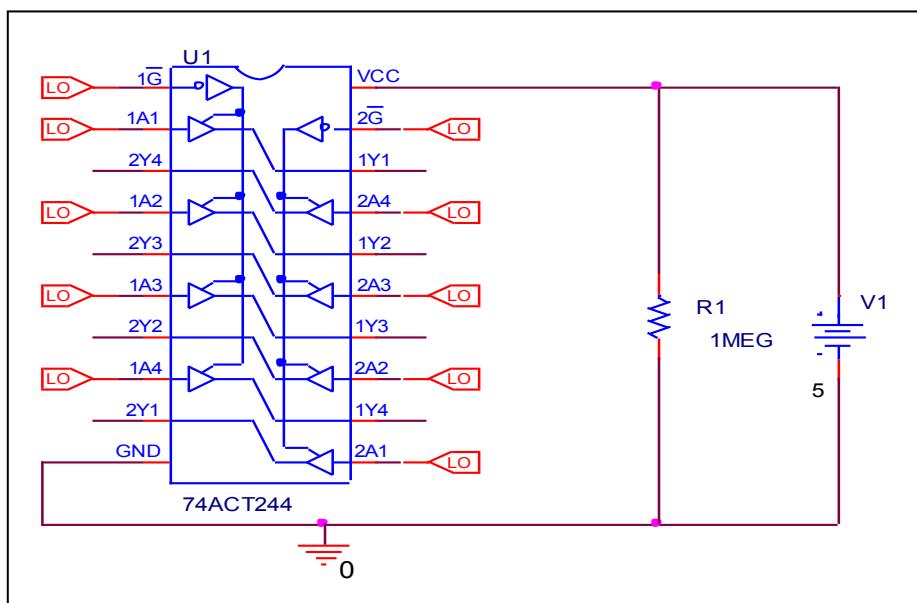
**Bee Technologies Inc.**

## Truth Table

Circuit simulation result



Evaluation circuit

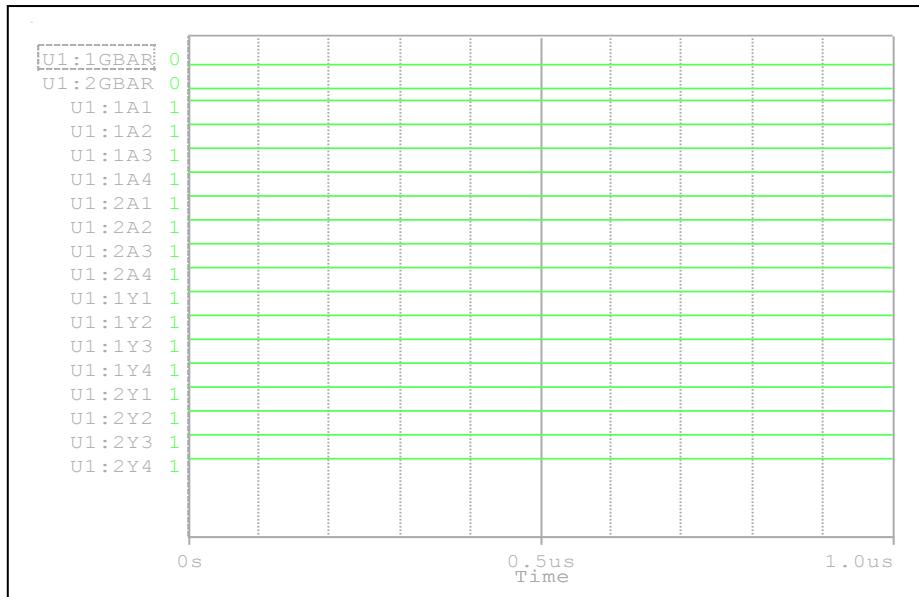


Comparison table

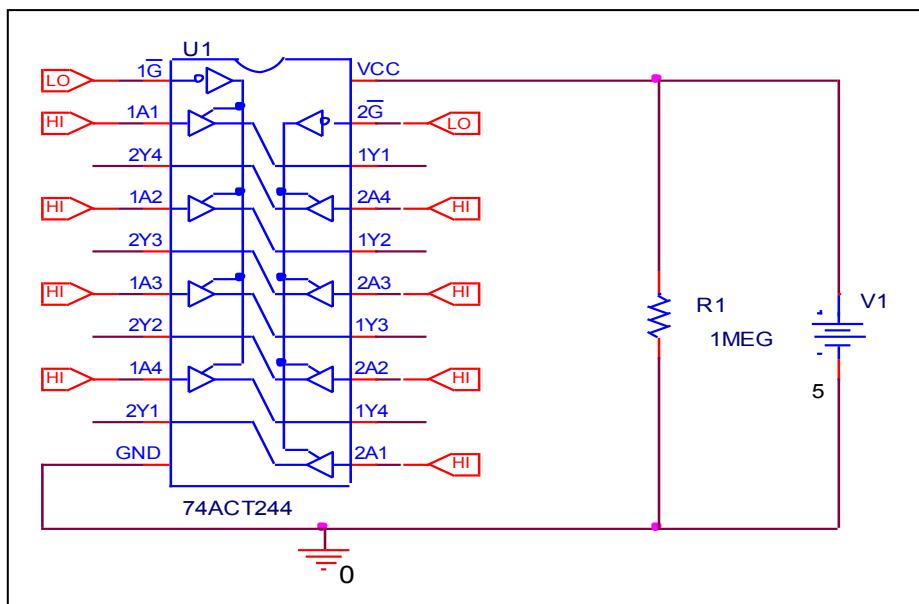
Input		Output		%Error
$\bar{G}$	An	$Y_n$ (Measurement)	$Y_n$ (Simulation)	
L	L	L	L	0

## Truth Table

Circuit simulation result



Evaluation circuit

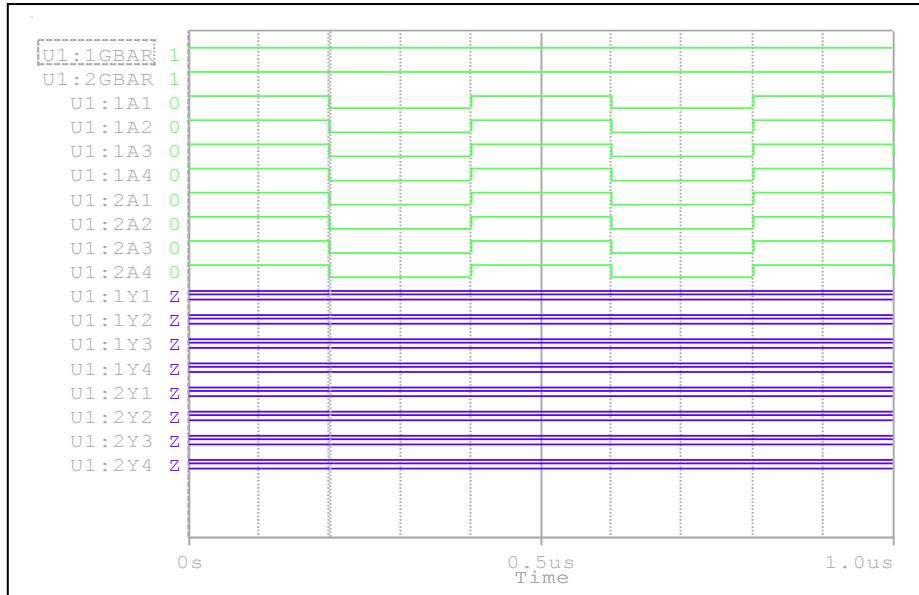


Comparison table

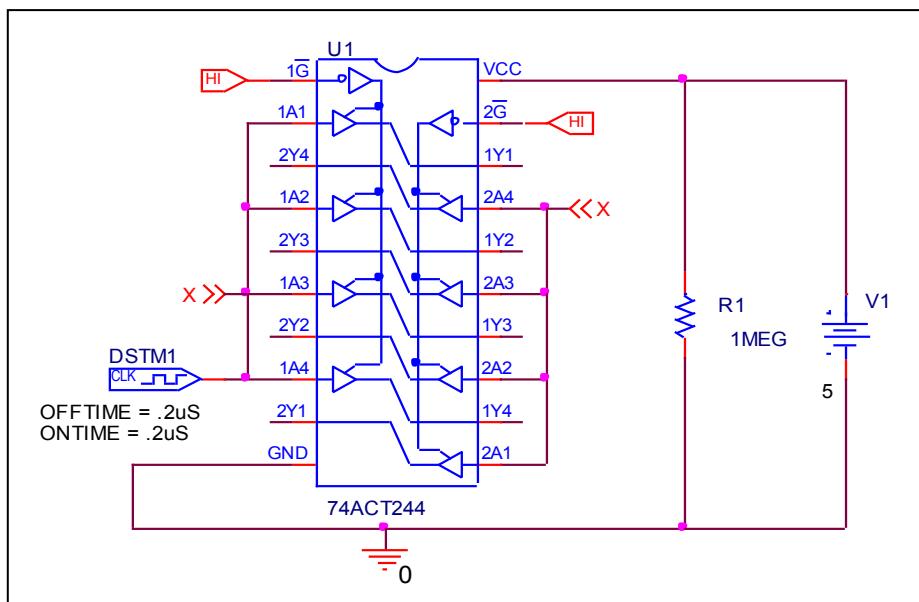
Input		Output		%Error
$\bar{G}$	An	$Y_n$ (Measurement)	$Y_n$ (Simulation)	
L	H	H	H	0

## Truth Table

Circuit simulation result



Evaluation circuit

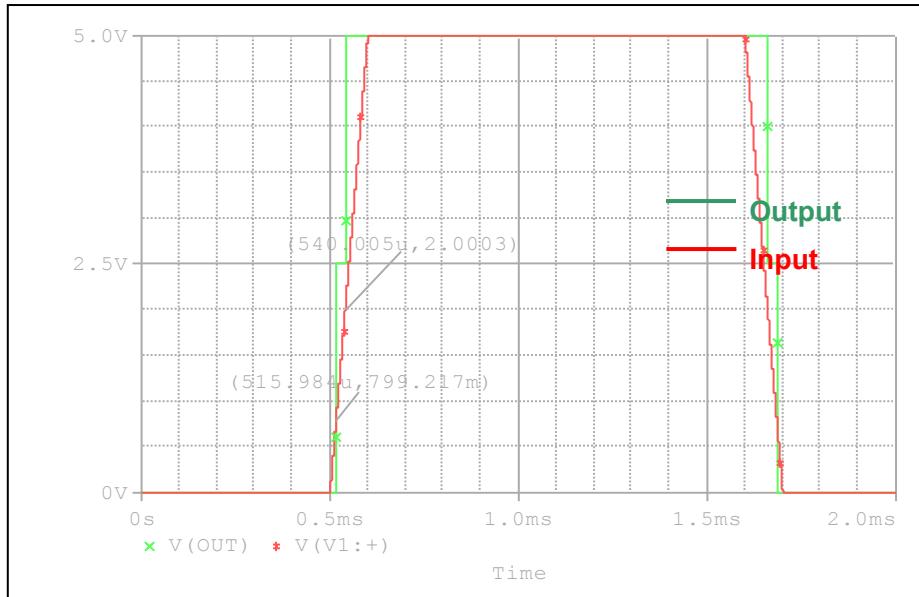


Comparison table

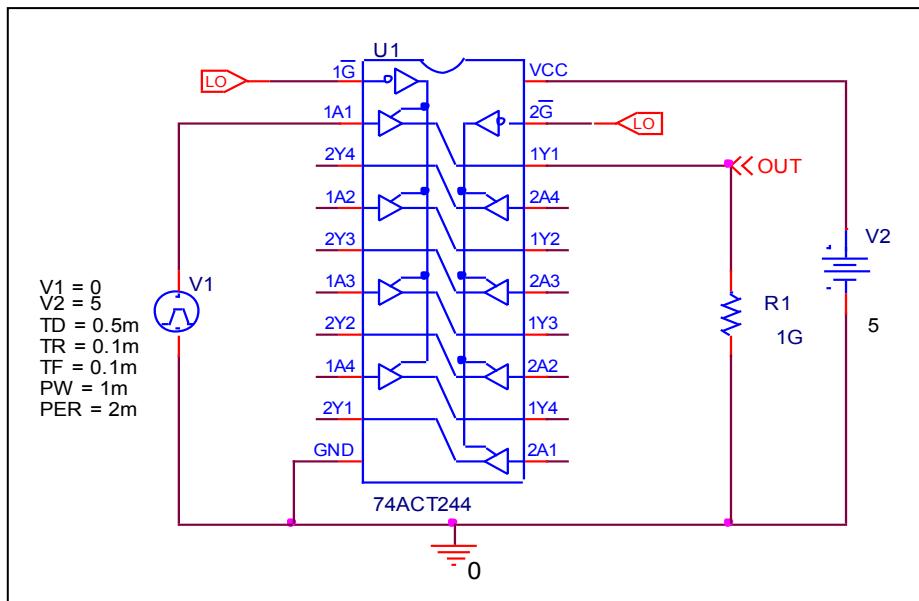
Input		Output		%Error
$\bar{G}$	An	Yn (Measurement)	Yn (Simulation)	
H	X	Z	Z	0

## High Level and Low Level Input Voltage

Circuit simulation result



Evaluation circuit

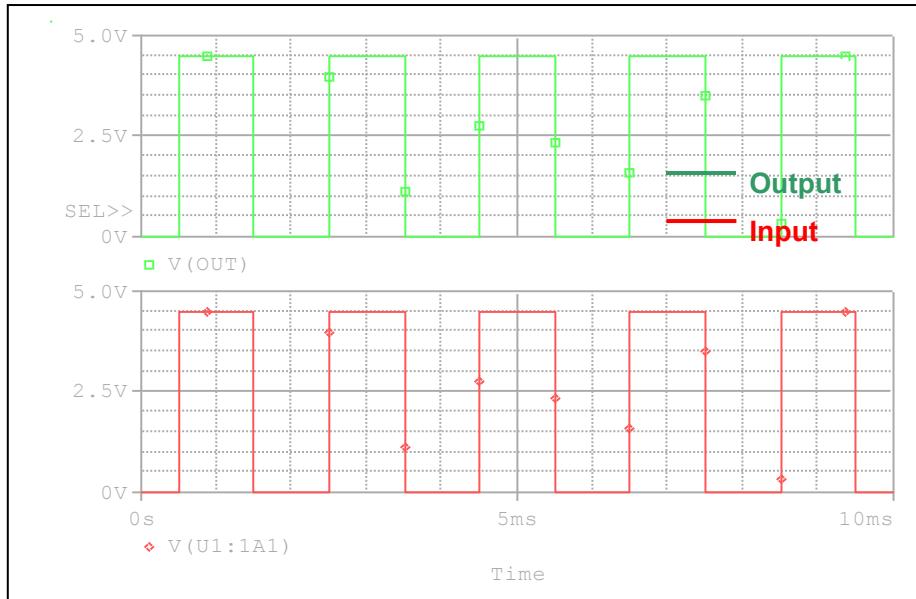


Comparison table

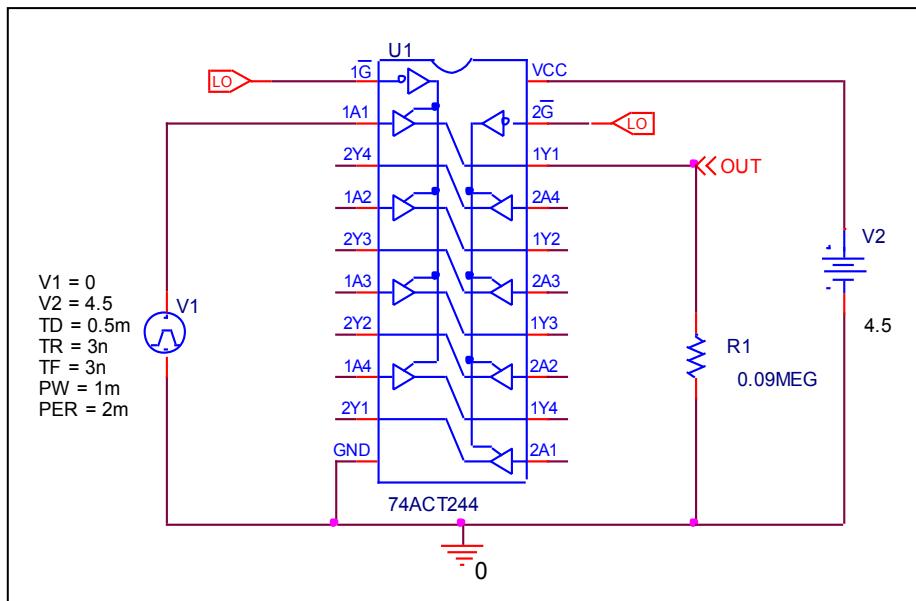
$V_{CC} = 5V$	Measurement	Simulation	%Error
$V_{IH} (V)$	2	2	0
$V_{IL} (V)$	0.8	0.799217	-0.098

## High Level and Low Level Output Voltage

Circuit simulation result



Evaluation circuit

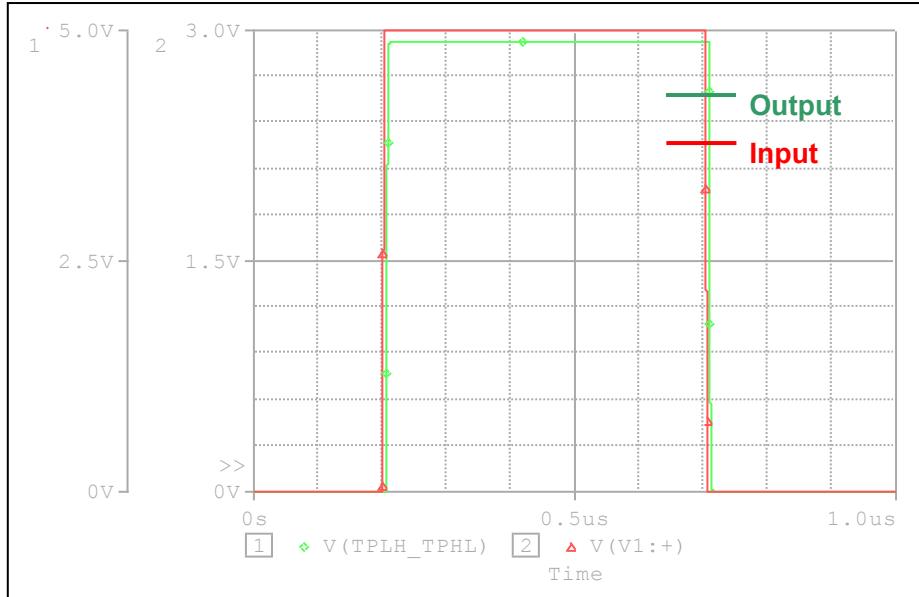


Comparison table

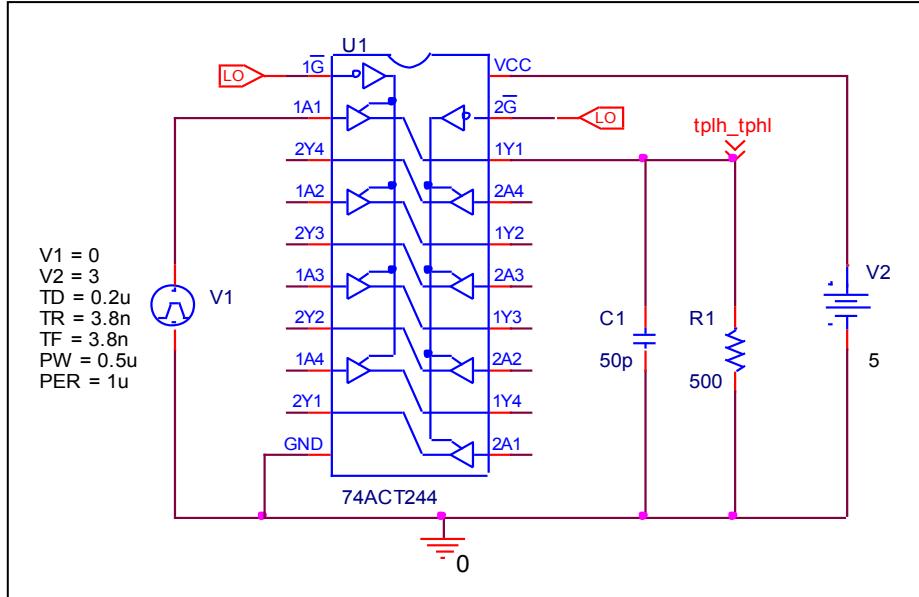
$V_{cc} = 4.5V$	Measurement	Simulation	%Error
$V_{OH} (V)$	4.5	4.4988	-0.027
$V_{OL} (V)$	0	0	0

## Propagation Delay Time

Circuit simulation result



Evaluation circuit

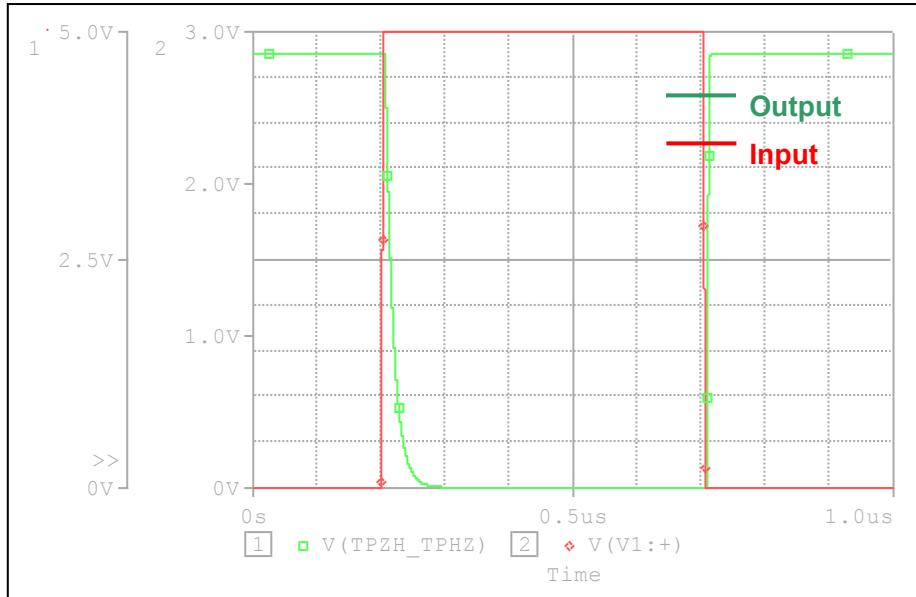


Comparison table  $C_L = 50 \text{ pF}$ ,  $R_L = 500 \Omega$

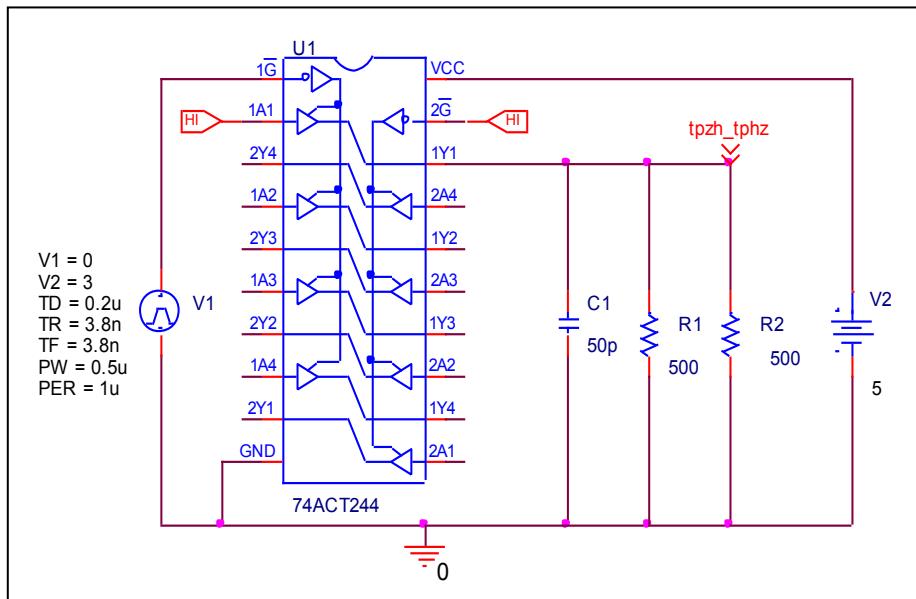
$t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{PLH} (\text{ns})$	5.7	5.8228	2.154
$t_{PHL} (\text{ns})$	5.7	5.7411	0.721

**Output enable time, high impedance (off) to high output ( $t_{PZH}$ )**  
**Output disable time, high to high impedance (off) output ( $t_{PHZ}$ )**

Circuit simulation result



Evaluation circuit

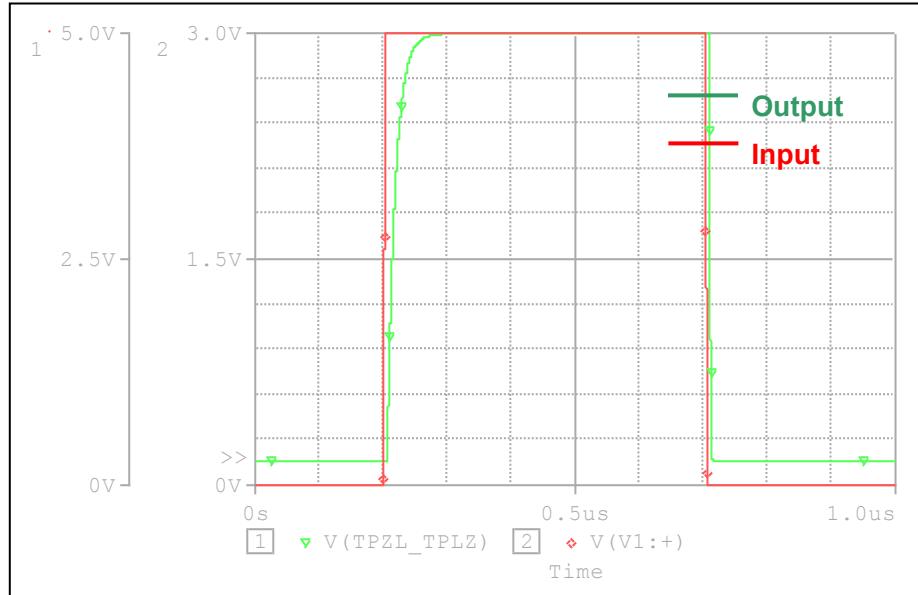


Comparison table    $C_L = 50 \text{ pF}$ ,  $R_L = 500 \Omega$

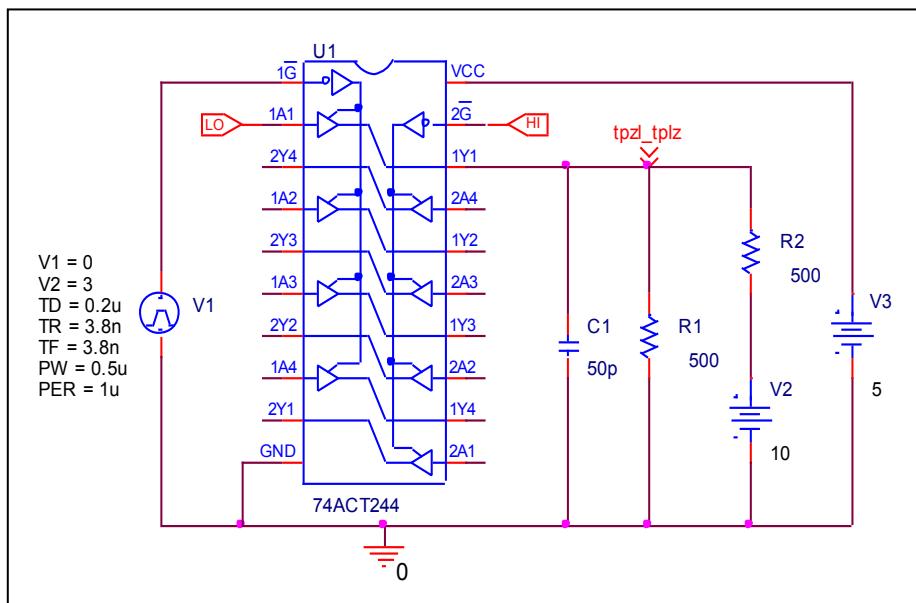
$t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{PZH} (\text{ns})$	6	6.0132	0.220
$t_{PHZ} (\text{ns})$	5.9	5.9843	1.429

**Output enable time, high impedance (off) to low output ( $t_{PZL}$ )**  
**Output disable time, low to high impedance (off) output ( $t_{PLZ}$ )**

Circuit simulation result



Evaluation circuit



Comparison table  $C_L = 50 \text{ pF}$ ,  $R_L = 500 \Omega$

$t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{PZL} (\text{ns})$	6	5.9928	-0.120
$t_{PLZ} (\text{ns})$	5.9	5.9245	0.415